Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,053	YAJNIK ET AL.	
Examiner	Art Unit	

2616

Sai-Ming Chan

SEARCHED					
Class	Subclass	Date	Examiner		
370	. 351	2/20/2007	sc		
709	217	2/20/2007	sc		
711	113.	2/21/2007	sc		
711	118	2/21/2007	sc		
711	137	2/22/2007	sc		
Updated	search	12/17/2007	sc		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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(INCLUDING SEARCH		•
* ****	DATE	EXMR
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	2/22/2007	sc
Updated search	12/17/2007	sc
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